

<b>Notice of References Cited</b>	Application/Control No. 10/615,168	Applicant(s)/Patent Under Reexamination LIU ET AL.	
	Examiner Steven M Marsh	Art Unit 3632	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,478,275 B1	11-2002	Huang, Min Hwa	248/284.1
	B	US-5,366,197	11-1994	Westland, Donald	248/456
	C	US-5,144,290	09-1992	Honda et al.	345/156
	D	US-5,138,565	08-1992	Satou, Youji	361/681
	E	US-5,704,581	01-1998	Chen, Ping	248/371
	F	US-6,727,961 B2	04-2004	Yang, Rowell	349/58
	G	US-6,712,321 B1	03-2004	Su et al.	248/123.11
	H	US-6,268,997 B1	07-2001	Hong, Yu-Sik	361/681
	I	US-5,923,528	07-1999	Lee, Roger	361/681
	J	US-6,561,469 B1	05-2003	Masuda et al.	248/163.1
	K	US-5,085,394	02-1992	Torii, Katsuhiro	248/455
	L	US-6,445,385 B1	09-2002	Shin et al.	345/204
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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